Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
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Examiner	Art Unit

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SEARCHED							
Class	Subclass	Date	Examiner				
382	173, 176	6/8/08	YH				
707	2-4, 104.1	6/8/08	YH				
715	501.1, 513	6/8/08	YH				

Hung, Yubin

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)	6/8/08	YH		
Inventor and assignee search	12/21/07	YH		
ACM	12/21/07	YH		
IEEE Xplore	12/21/07	YH		
SPIE	12/21/07	YH		

INTERFERENCE SEARCH							
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